Sear	cn No	otes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/731,312	MCELVAIN ET AL.
Examiner	Art Unit
Leigh Marie Garbowski	2825

SEARCHED			
Class	Subclass	Date	Examiner
716	1-2,4,7,11, 17-18	7/5/2005	LMG
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TNI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
716	7,11,18	- 7/5/2005	LMG	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
WEST and IEEExplore search terms partition/ing rtl technology in/dependent first/second ic multiple ic vendor specific	7/5/2005	LMG
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